

INTERFERENCE SEARCHED					
Class	Sub.	Date	Exmr.		
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## SEARCH NOTES (INCLUDING SEARCH STRATEGY

(INCLUDING SEARCH STRATEGY)				
EAST, LEM, TERE	Date	Exmr		
see seeved notes affected inside (Fault simulation, transient current baced testing)	io(28/03	ayal		
6157 ACM ZEGE See search note attached inside	4/21/04	ayee		
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